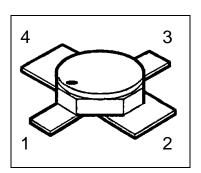


HiRel NPN Silicon RF Transistor

- HiRel Discrete and Microwave Semiconductor
- For low noise, high-gain broadband amplifiers at collector currents from 2mA to 30mA.
- Hermetically sealed microwave package
- f_T= 8 GHz
 F = 2.3 dB at 2 GHz

ESA/SCC Detail Spec. No.: 5611/006

Type Variant No. 05



ESD: Electrostatic discharge sensitive device, observe handling precautions!

Туре	Marking	Ordering Code	Pin Configuration		Package		
BFY183 (ql)	-	see below	С	Е	В	Е	Micro-X1

(ql) Quality Level: P: Professional Quality

H: High Rel QualityS: Space Quality

ES: ESA Space Quality

(see order instructions for ordering example)



Maximum Ratings					
Parameter	Symbol	Values	Unit		
Collector-emitter voltage	V_{CEO}	12	V		
Collector-emitter voltage, V _{BE} =0	V_{CES}	20	V		
Collector-base voltage	V_{CBO}	20	V		
Emitter-base voltage	V_{EBO}	2	V		
Collector current	Ic	65	mA		
Base current	I _B	5 ^{1.)}	mA		
Total power dissipation, $T_S \le 99^{\circ}C^{2.)}$	P _{tot}	450	mW		
Junction temperature	T _j	200	°C		
Operating temperature range	T _{op}	-65+200	°C		
Storage temperature range	T_{stg}	-65+200	°C		
Thermal Resistance	•	•	•		
Junction-soldering point ^{2.)}	R _{th JS}	< 225	K/W		
		•			

Notes.:

Electrical Characteristics

at T_A=25°C; unless otherwise specified

Parameter	Symbol	Values			Unit	
		min.	typ.	max.		
DC Characteristics						
Collector-base cutoff current	I _{CBO}	-	-	100	μΑ	
$V_{CB} = 20 \text{ V}, I_E = 0$						
Collector-emitter cutoff current	I _{CEX}	-	-	300	μΑ	
$V_{CE} = 12 \text{ V}, I_B = 0.3 \mu A^{-1.0}$						
Collector-base cutoff current	I _{CBO}	-	-	50	nA	
$V_{CB} = 10 \text{ V}, I_{E} = 0$						
Emitter base cuttoff current	I _{EBO}	-	-	25	μΑ	
$V_{EB} = 2 \text{ V}, I_{C} = 0$						
Emitter base cuttoff current	I _{EBO}	-	-	0.5	μΑ	
$V_{EB} = 1 \text{ V}, I_C = 0$						

Notes:

1.) This Test assures V(BR)CE0 > 12V

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¹⁾ The maximum permissible base current for V_{FBE} measurements is 20mA (spot-measurement duration < 1s)

²⁾ T_S is measured on the collector lead at the soldering point to the pcb.



Electrical Characteristics (continued)

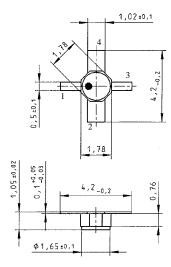
Parameter	Symbol		Values	3	Unit
		min.	typ.	max.	
DC Characteristics					·
Base-Emitter forward voltage	V _{FBE}	-	-	1	V
$I_E = 30 \text{ mA}, I_C = 0$					
DC current gain	h _{FE}	55	90	160	-
$I_C = 5 \text{ mA}, V_{CE} = 6 \text{ V}$					
AC Characteristics					
Transition frequency	f_{T}				GHz
I_C = 20 mA, V_{CE} = 5 V, f = 500 MHz		6,5	7.5	-	
$I_C = 25 \text{ mA}, V_{CE} = 8 \text{ V}, f = 500 \text{ MHz}$		-	8	-	
Collector-base capacitance	C _{CB}	-	0.32	0.44	pF
$V_{CB} = 10 \text{ V}, V_{BE} = \text{vbe} = 0, f = 1 \text{ MHz}$					
Collector-emitter capacitance	C _{CE}	-	0.34	-	pF
$V_{CE} = 10 \text{ V}, V_{BE} = \text{vbe} = 0, f = 1 \text{ MHz}$					
Emitter-base capacitance	C _{EB}	-	1.1	1.4	pF
$V_{EB} = 0.5V$, $V_{CB} = vcb = 0$, $f = 1 MHz$					
Noise Figure	F	-	2.3	2.9	dB
I_C = 8 mA, V_{CE} = 5 V, f = 2 GHz, Z_S = Z_{Sopt}					
Power gain	Gma 1.)	12.5	14	-	dB
$I_C = 20$ mA, $V_{CE} = 5V$, $f = 2$ GHz					
$Z_S = Z_{Sopt}$, $Z_L = Z_{Lopt}$					
Transducer gain	$\left S_{21e}\right ^2$	9	10,5	-	dB
I_C = 20 mA, V_{CE} = 5 V, f = 2 GHz					
$Z_S = Z_L = 50 \Omega$					
Output Power	P _{OUT}	13.5	14.5	-	dBm
I_C = 30 mA, V_{CE} = 5 V, f = 2GHz , P_{IN} =7dBm					
$Z_S = Z_L = 50 \Omega$					

Notes.:

1)
$$G_{ma} = \left| \frac{S21}{S12} \right| (k - \sqrt{k^2 - 1}), \quad G_{ms} = \left| \frac{S21}{S12} \right|$$



Micro-X1 Package



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